Notice of References Cited 10/679,273 Reexamination OOTERA, YASUAKI Examiner Art Unit

Examiner Art Unit
ALI NEYZARI 2627 Page 1 of 1

Applicant(s)/Patent Under

U.S. PATENT DOCUMENTS

Application/Control No.

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,556,537	04-2003	Endoh, Sohmei	369/275.4
*	В	US-6,819,650	11-2004	Deno et al.	369/275.4
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-	-		
	1	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	2					
	0					
	Р					
	α					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.